

Supplementary Information

Solution-Processed Yolk-Shell-Shaped $\text{WO}_3/\text{BiVO}_4$ Heterojunction

Photoelectrode for Efficient Solar Water Splitting

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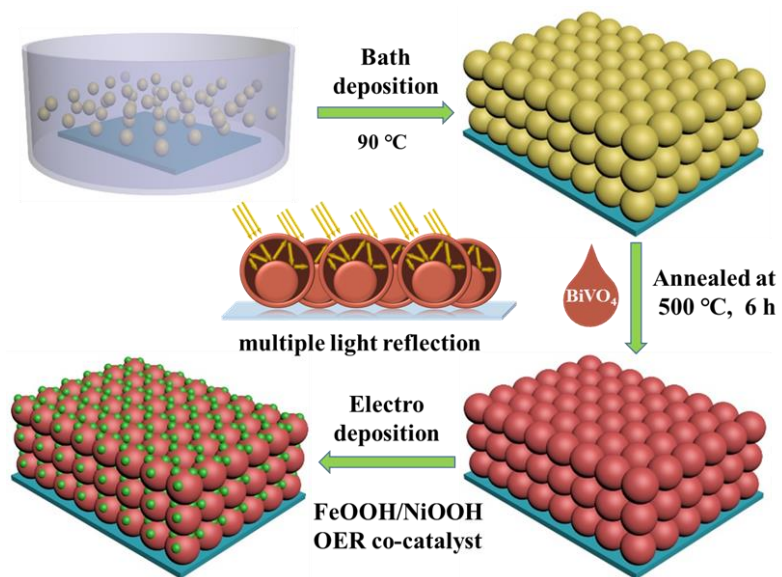
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Scheme S1 Schematic diagram of the fabrication process for the $\text{WO}_3/\text{BiVO}_4/\text{OER}$ photoanodes and multiple light reflection of yolk-shell structure WO_3 .

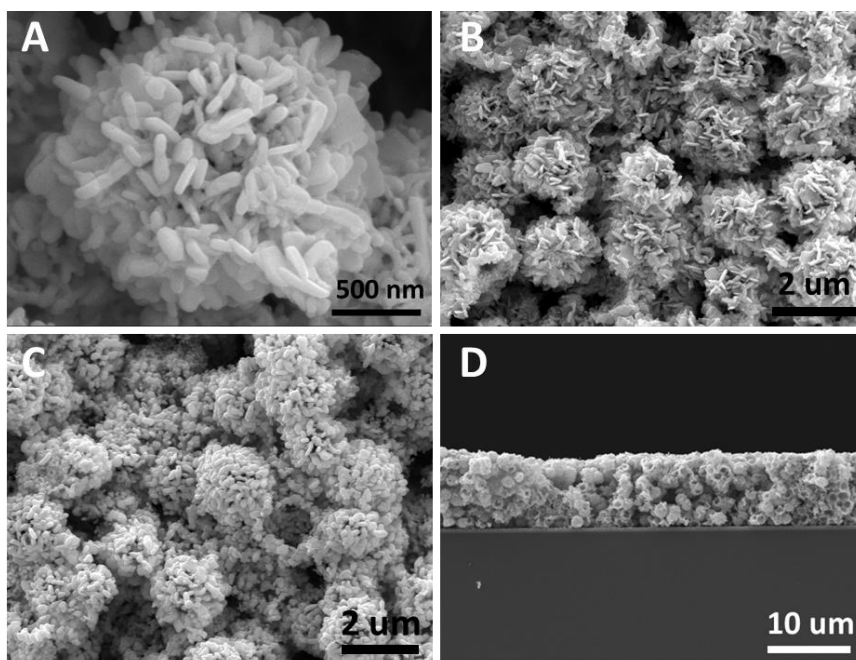


Fig. S1 Top-view images of (A, B) yolk-shell $\text{WO}_3/\text{BiVO}_4$ heterojunction with $80 \mu\text{l}$ of BiVO_4 and (C) modified with OER co-catalyst; (D) Cross-sectional images of the yolk-shell $\text{WO}_3/\text{BiVO}_4$ heterojunction.

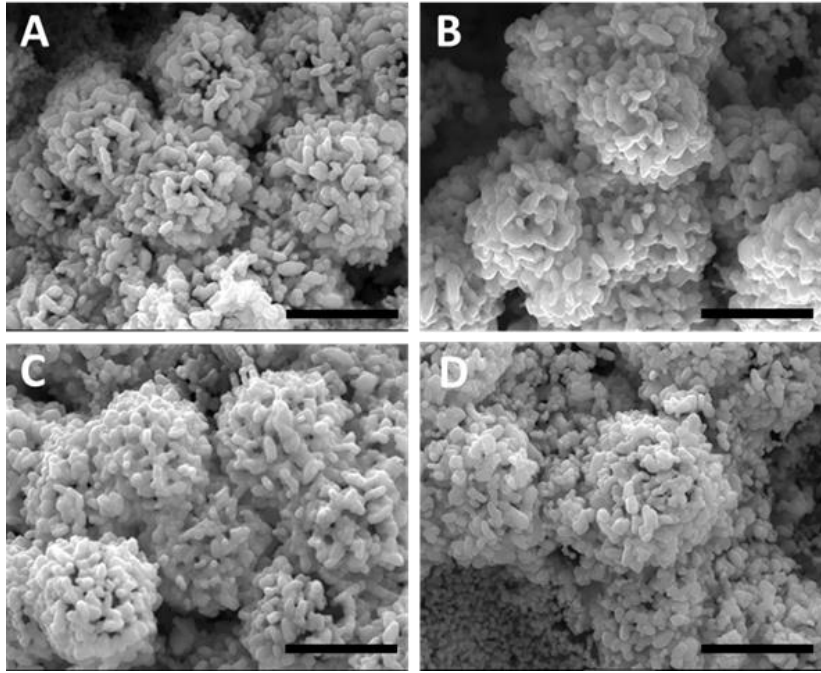


Fig. S2 Top-view SEM images of Y-WO₃/BiVO₄ with different amounts of BiVO₄: (A) 40 μ l, (B) 60 μ l, (C) 80 μ l, and (D) 100 μ l (scale bars are 2 μ m).

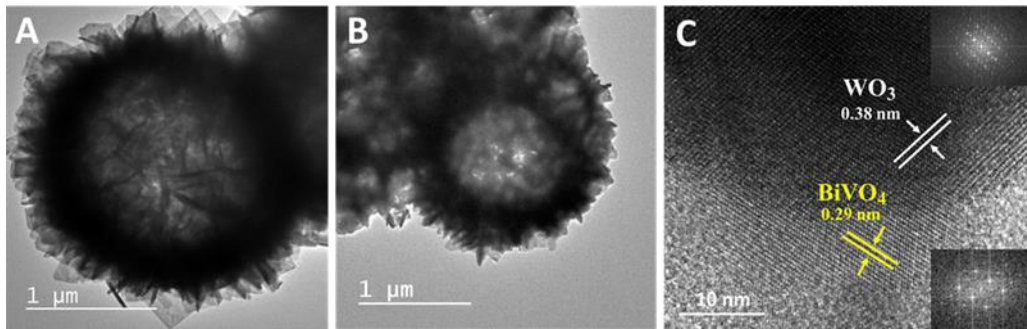


Fig. S3 TEM images of (A) WO₃ nanosphere; (B) WO₃/BiVO₄ heterojunction after coating with BiVO₄ layer; and (C) HR-TEM images of WO₃/BiVO₄ heterojunction, the insets are the corresponding selected-area electron diffraction patterns.

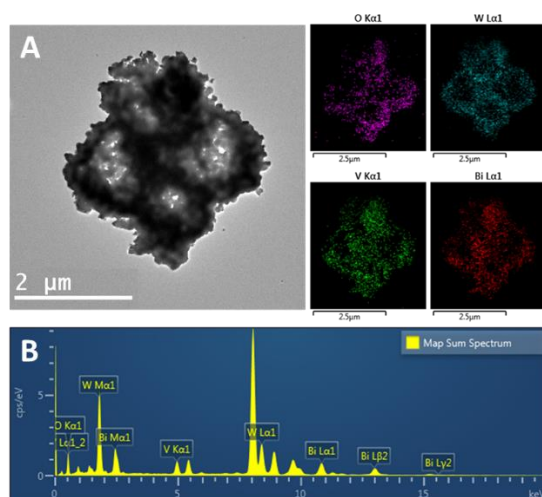


Fig. S4 (A) TEM images of WO₃/BiVO₄ heterojunction and the corresponding surface elements distribution; (B) EDX of WO₃/BiVO₄ heterojunction.

It can be seen from Fig. S3 that after coating with BiVO₄ to form WO₃/BiVO₄ heterojunction (B), the heterojunction still remain the original structure relatively which was also displayed by the SEM image at Fig.1C in the manuscript. The BiVO₄ layer and the corresponding elements of the uniform dispersion of the Bi and V elements are also be showed in Fig. S4, which suggesting the BiVO₄ was uniformly combined with WO₃. The lattice spacing of 0.38 nm in Fig. S3C is well matched with the (002) crystalline plane of monoclinic WO₃ and the measured lattice spacing of 0.29 nm corresponds the (040) plane of monoclinic BiVO₄, while the selected area electron diffraction patterns indicate that the crystal lattice fringes observed originate from (002) WO₃ and (040) BiVO₄. On the other hand, the SAED pattern indicates the single-crystal feature with the typical crystal zone axis of [001]. Overall, it indicates that the BiVO₄ layer can cover the entire surface of the WO₃ nanospheres through our method, the well-defined interface is also important for charge separation in the heterojunction.

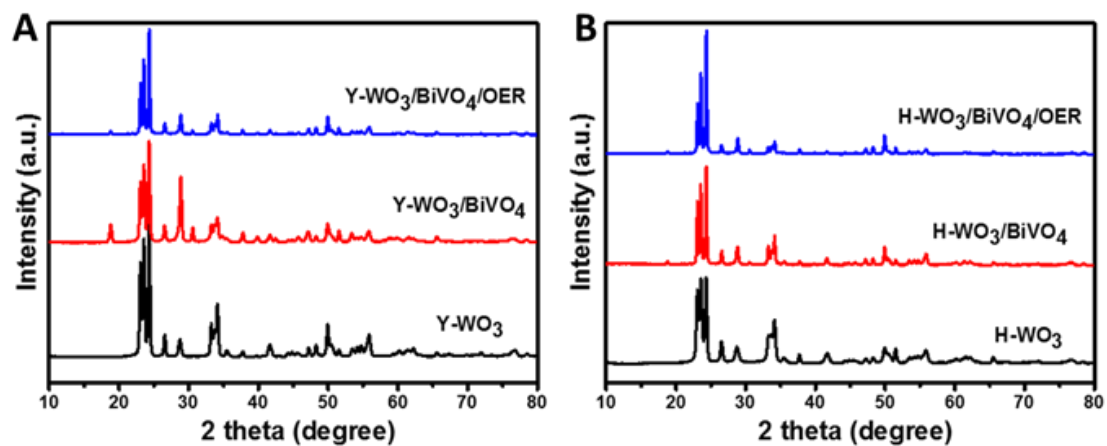


Fig. S5 XRD patterns of (A): the yolk-shell WO₃, Y-WO₃/BiVO₄ and Y-WO₃/BiVO₄/OER samples; (B): the hollow WO₃, H-WO₃/BiVO₄ and H-WO₃/BiVO₄/OER samples.

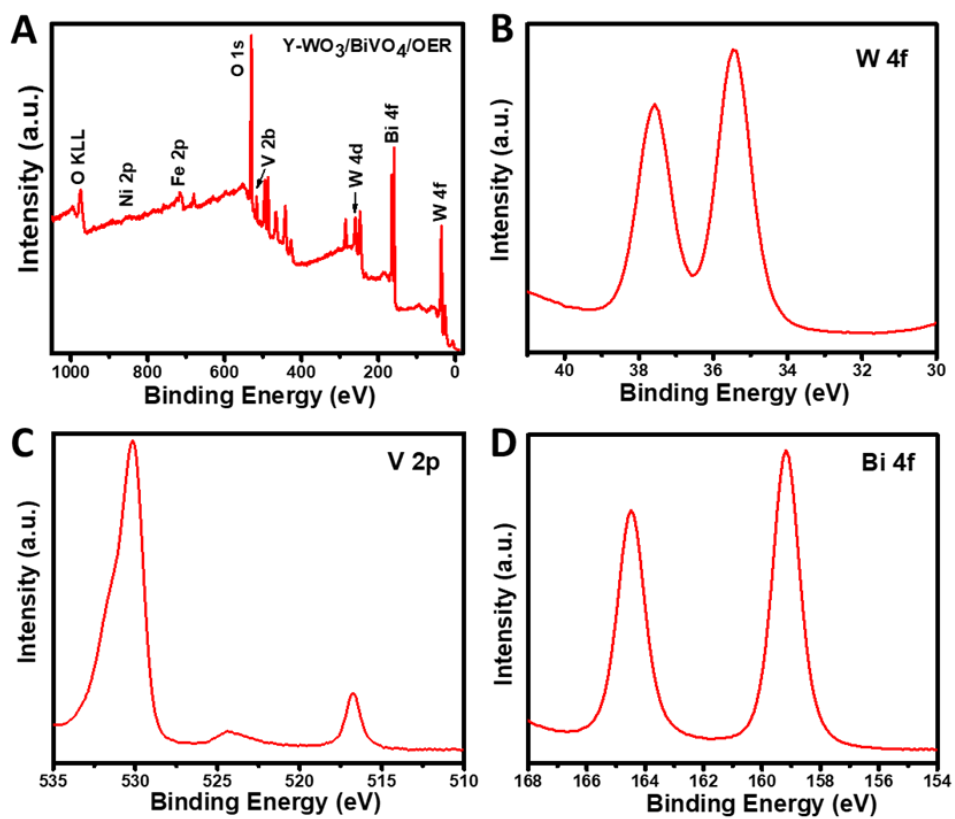


Fig. S6 (A) XPS spectra of a survey scan of Y-WO₃/BiVO₄/OER and the corresponding XPS elemental spectra of (B) W 4f, (C) V 2p, and (D) Bi 4f.

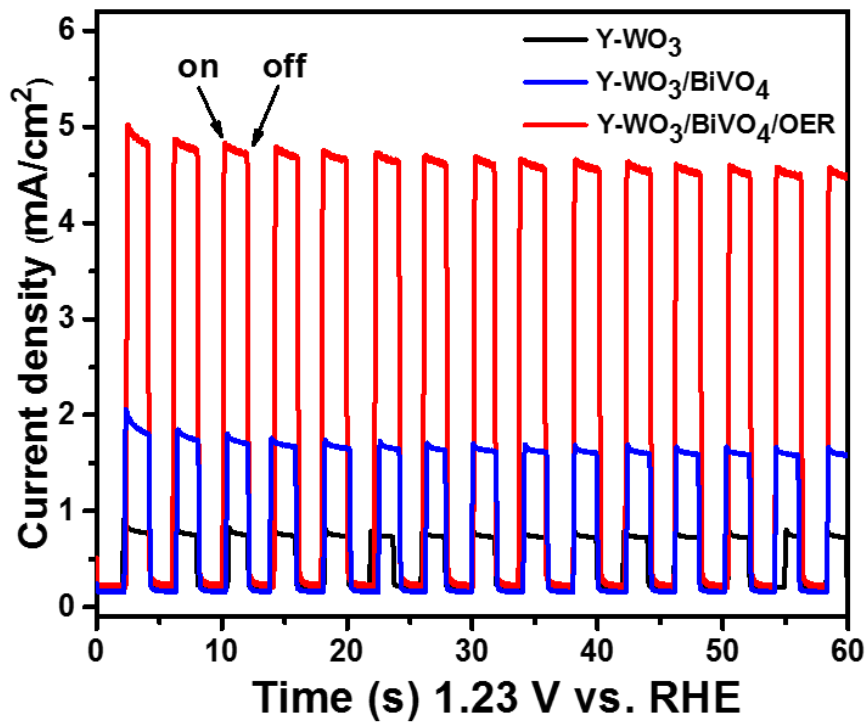


Fig. S7 Photocurrent-time (I-t) curves of the samples (the amount of BiVO₄ precursor is 80 μ l) in a 0.5 M Na₂SO₄ solution under AM 1.5G light illumination at 1.23 V (vs. RHE).

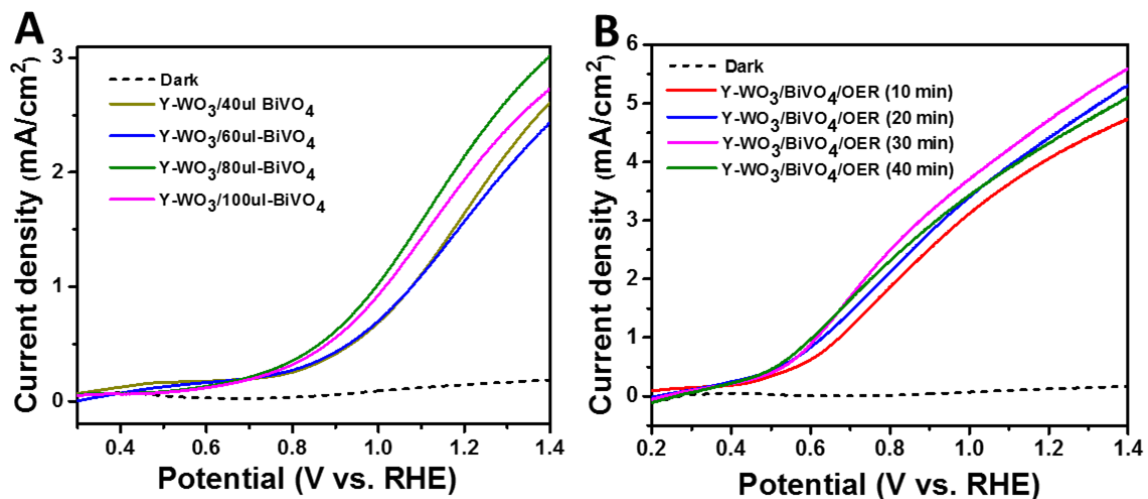


Fig. S8 LSV scans of Y-WO₃/BiVO₄ (A) with various amount of BiVO₄ precursor and (B) with different electrodeposition times of the OER co-catalyst layer.

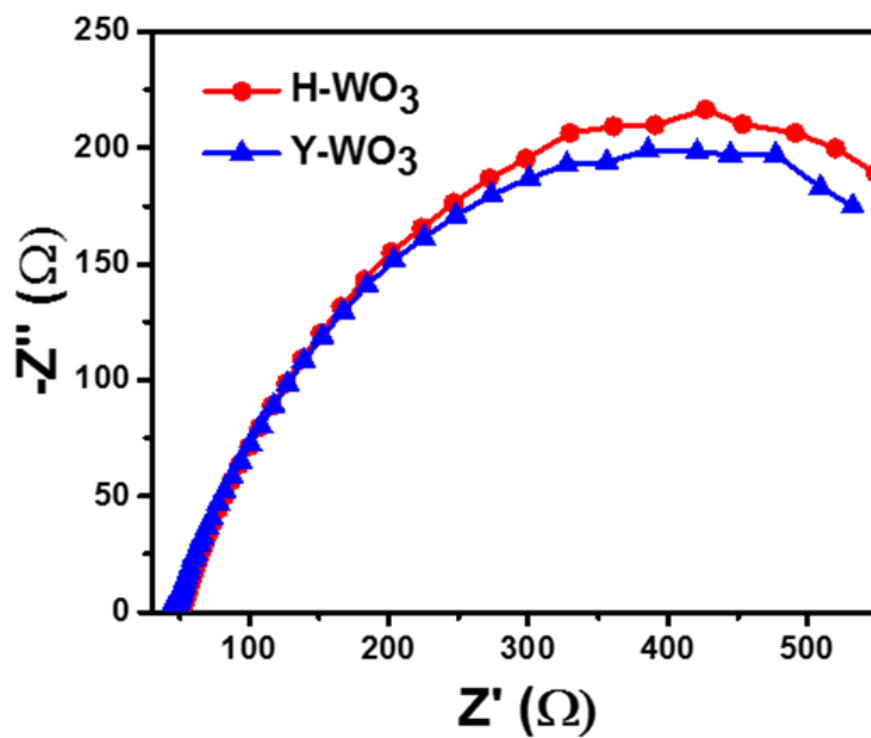


Fig. S9 Nyquist plots of the hollow WO₃ and yolk-shell WO₃ photoanodes at 1.23 V (vs. RHE).

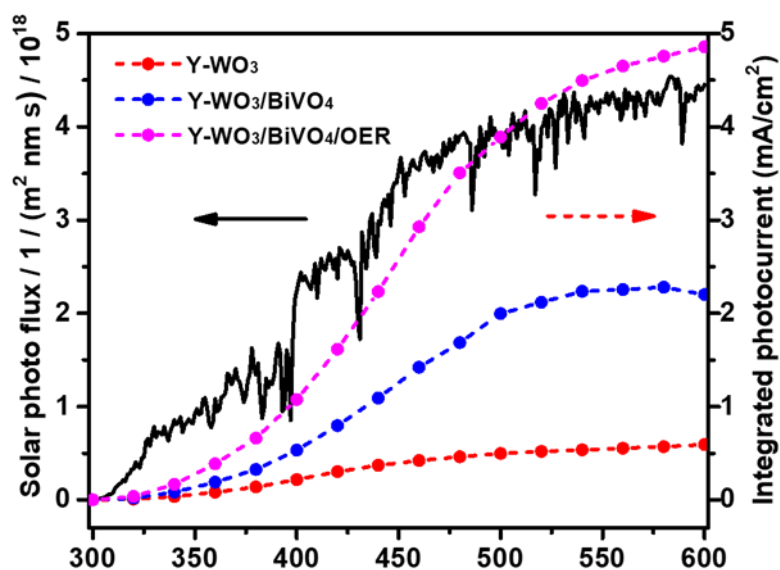


Fig. S10 Integrated photocurrent over the standard solar spectrum dependence on the IPCE on wavelength for the photoanodes at 1.23 V vs. RHE.

Discussion:

The photocurrent ($I(\lambda)$) was predicted by convolution of the IPCE spectra with the photo flux density distribution as the following equation,

$$I(\lambda) = \int qF(\lambda)IPCE(\lambda)d\lambda$$

where q is the electron charge and $F(\lambda)$ is the incident photon flux density (AM 1.5, ASTM G173) at wavelength λ , IPCE(λ) data is shown in Fig. 3D in the manuscript.

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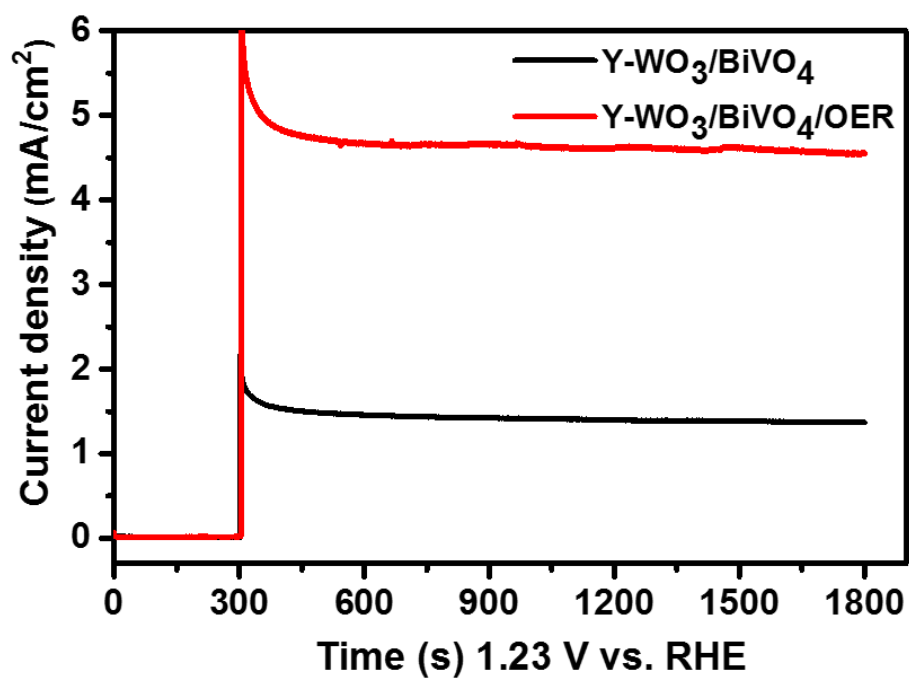


Fig. S11 Photocurrent stability of the Y-WO₃/BiVO₄ and Y-WO₃/BiVO₄/OER photoanode at 1.23 V vs. RHE.

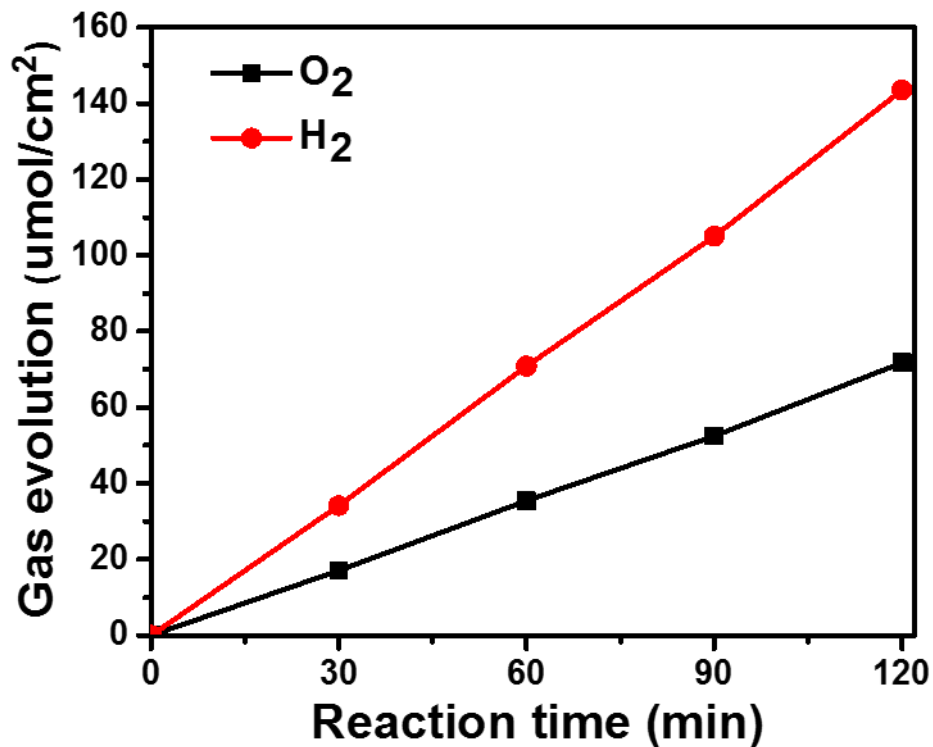


Fig. S12 H₂ and O₂ evolution at 1.2 V versus the Pt counter electrode of the Y-WO₃/BiVO₄/OER photoanode.

The faradaic efficiency for O₂ evolution is determined by the following equation:

$$\eta_{Faradaic} = \frac{4 \times N_{O_2} (mol) \times 96485 (Cmol^{-1})}{Q (C)}$$

where $\eta_{Faradaic}$ is the faradaic efficiency for photoelectrochemical water oxidation, N_{O_2} is the amount of oxygen, and Q is the total amount of generated charge ($Q = \text{photocurrent} \times \text{time}$). Therefore, the faradaic efficiency for O₂ evolution is calculated to be 87.7%. The loss of faradaic efficiency was possibly due to the limited kinetics of water oxidation and back reaction of H₂ and O₂.

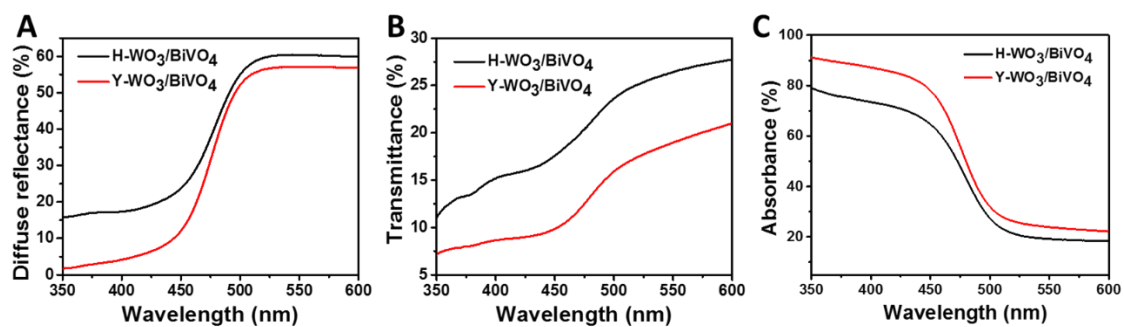


Fig. S13 (A) Diffuse reflectance curves, (B) transmittance spectra and (C) UV-vis absorption spectra of hollow $\text{WO}_3/\text{BiVO}_4$ and yolk-shell $\text{WO}_3/\text{BiVO}_4$.

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